

Device Pin Assignment

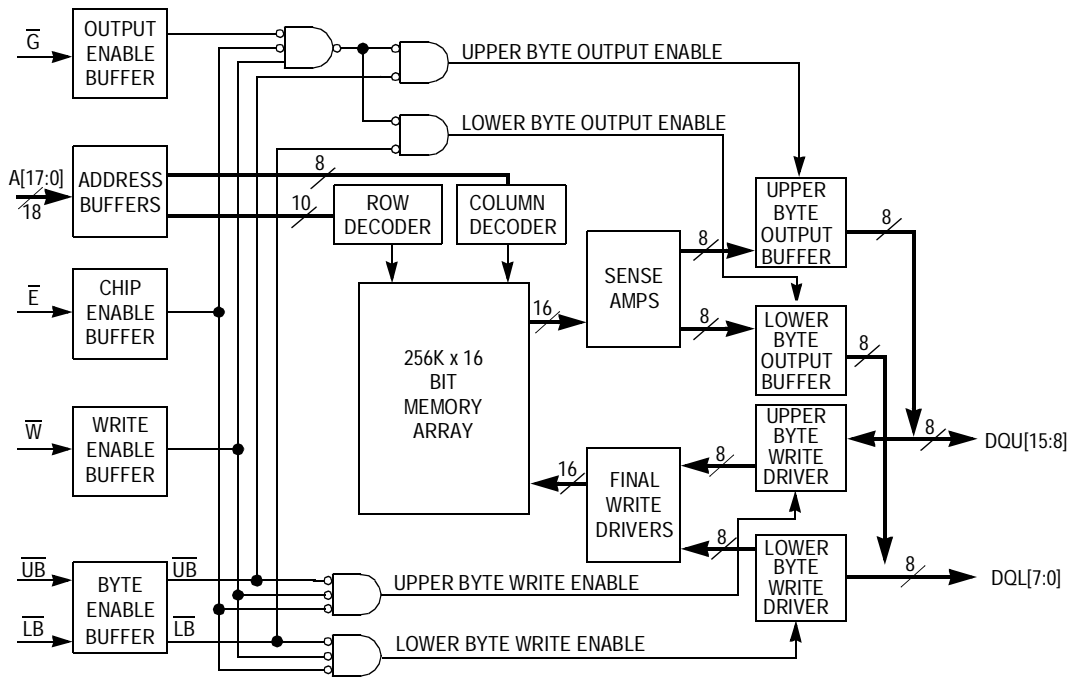


Figure 1. Block Diagram

Device Pin Assignment

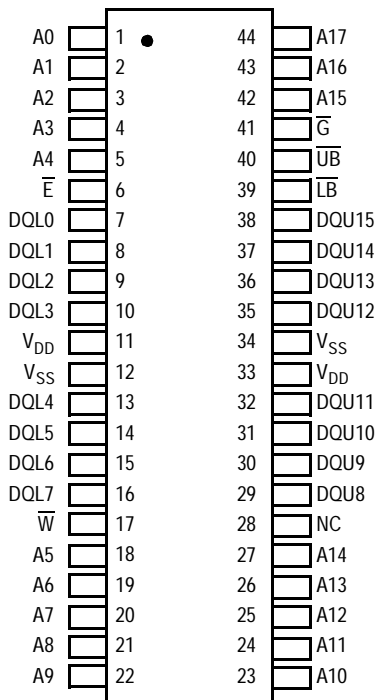


Table 1. Pin Functions

Signal Name	Function
A	Address input
\bar{E}	Chip enable
\bar{W}	Write enable
\bar{G}	Output enable
\bar{UB}	Upper byte select
\bar{LB}	Lower byte select
DQL	Data I/O, lower byte
DQU	Data I/O, upper byte
V_{DD}	Power supply
V_{SS}	Ground
NC	Do not connect this pin

Figure 2. MR2A16A in 44-Pin TSOP Type II Package

Table 2. Operating Modes

\bar{E}^1	\bar{G}^1	\bar{W}^1	\bar{LB}^1	\bar{UB}^1	Mode	V _{DD} Current	DQL[7:0] ²	DQU[15:8] ²
H	X	X	X	X	Not selected	I _{SB1} , I _{SB2}	Hi-Z	Hi-Z
L	H	H	X	X	Output disabled	I _{DDR}	Hi-Z	Hi-Z
L	X	X	H	H	Output disabled	I _{DDR}	Hi-Z	Hi-Z
L	L	H	L	H	Lower byte read	I _{DDR}	D _{Out}	Hi-Z
L	L	H	H	L	Upper byte read	I _{DDR}	Hi-Z	D _{Out}
L	L	H	L	L	Word read	I _{DDR}	D _{Out}	D _{Out}
L	X	L	L	H	Lower byte write	I _{DDW}	D _{In}	Hi-Z
L	X	L	H	L	Upper byte write	I _{DDW}	Hi-Z	D _{In}
L	X	L	L	L	Word write	I _{DDW}	D _{In}	D _{In}

NOTES:

- ¹ H = high, L = low, X = don't care
- ² Hi-Z = high impedance

Electrical Specifications

Absolute Maximum Ratings

This device contains circuitry to protect the inputs against damage caused by high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage greater than maximum rated voltages to these high-impedance (Hi-Z) circuits.

The device also contains protection against external magnetic fields. Precautions should be taken to avoid application of any magnetic field more intense than the maximum field intensity specified in the maximum ratings.

Table 4. Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit
Power supply voltage MR2A16ATS35C (Commercial - Legacy) MR2A16AYS35 (Commercial - New) MR2A16ACYS35 (Industrial) MR2A16AVYS35 (Extended)	V_{DD}	3.0 ¹ 3.0 ² 3.0 ² 3.0 ²	3.3 3.3 3.3 3.3	3.6 3.6 3.6 3.6	V
Write inhibit voltage MR2A16ATS35C (Commercial - Legacy) MR2A16AYS35 (Commercial - New) MR2A16ACYS35 (Industrial) MR2A16AVYS35 (Extended)	V_{WI}	2.5 2.5 2.5 2.5	2.7 2.7 2.7 2.7	3.0 ¹ 3.0 ² 3.0 ² 3.0 ²	V
Input high voltage	V_{IH}	2.2	—	$V_{DD} + 0.3$ ³	V
Input low voltage	V_{IL}	-0.5 ⁴	—	0.8	V
Operating temperature MR2A16ATS35C (Commercial - Legacy) MR2A16AYS35 (Commercial - New) MR2A16ACYS35 (Industrial) MR2A16AVYS35 (Extended)	T_A	0 0 -40 -40		70 70 85 105	°C

NOTES:

- After power up or if V_{DD} falls below V_{WI} , a waiting period of 2 μ s must be observed, and \bar{E} and \bar{W} must remain high for 2 μ s. Memory is designed to prevent writing for all input pin conditions if V_{DD} falls below minimum V_{WI} .
- After power up or if V_{DD} falls below V_{WI} , a waiting period of 2 ms must be observed, and \bar{E} and \bar{W} must remain high for 2 ms. Memory is designed to prevent writing for all input pin conditions if V_{DD} falls below minimum V_{WI} .
- $V_{IH}(\text{max}) = V_{DD} + 0.3 \text{ Vdc}$; $V_{IH}(\text{max}) = V_{DD} + 2.0 \text{ Vac}$ (pulse width $\leq 10 \text{ ns}$) for $I \leq 20.0 \text{ mA}$.
- $V_{IL}(\text{min}) = -0.5 \text{ Vdc}$; $V_{IL}(\text{min}) = -2.0 \text{ Vac}$ (pulse width $\leq 10 \text{ ns}$) for $I \leq 20.0 \text{ mA}$.

Electrical Specifications

Direct Current (dc)

Table 5. dc Characteristics

Parameter	Symbol	Min	Typ	Max	Unit
Input leakage current	$I_{lkg(I)}$	—	—	±1	μA
Output leakage current	$I_{lkg(O)}$	—	—	±1	μA
Output low voltage ($I_{OL} = +4 \text{ mA}$) ($I_{OL} = +100 \mu\text{A}$)	V_{OL}	—	—	0.4 $V_{SS} + 0.2$	V
Output high voltage ($I_{OH} = -4 \text{ mA}$) ($I_{OH} = -100 \text{ mA}$)	V_{OH}	2.4 $V_{DD} - 0.2$	—	—	V

Table 6. Power Supply Characteristics

Parameter	Symbol	Typ	Max	Unit
ac active supply current — read modes ¹ ($I_{Out} = 0 \text{ mA}$, $V_{DD} = \text{max}$)	I_{DDR}	55	80	mA
ac active supply current — write modes ¹ ($V_{DD} = \text{max}$) MR2A16ATS35C (Commercial - Legacy) MR2A16AYS35 (Commercial - New) MR2A16ACYS35 (Industrial) MR2A16AVYS35 (Extended)	I_{DDW}	105 105 105 105	155 155 165 165	mA
ac standby current ($V_{DD} = \text{max}$, $\bar{E} = V_{IH}$) (no other restrictions on other inputs)	I_{SB1}	18	28	mA
CMOS standby current ($\bar{E} \geq V_{DD} - 0.2 \text{ V}$ and $V_{In} \leq V_{SS} + 0.2 \text{ V}$ or $\geq V_{DD} - 0.2 \text{ V}$) ($V_{DD} = \text{max}$, $f = 0 \text{ MHz}$)	I_{SB2}	9	12	mA

NOTES:

¹ All active current measurements are measured with one address transition per cycle.

Table 7. Capacitance¹

Parameter	Symbol	Typ	Max	Unit
Address input capacitance	C_{In}	—	6	pF
Control input capacitance	C_{In}	—	6	pF
Input/output capacitance	$C_{I/O}$	—	8	pF

NOTES:

¹ $f = 1.0 \text{ MHz}$, $dV = 3.0 \text{ V}$, $T_A = 25^\circ\text{C}$, periodically sampled rather than 100% tested.

Table 8. ac Measurement Conditions

Parameter	Value
Logic input timing measurement reference level	1.5 V
Logic output timing measurement reference level	1.5 V
Logic input pulse levels	0 or 3.0 V
Input rise/fall time	2 ns
Output load for low and high impedance parameters	See Figure 3A
Output load for all other timing parameters	See Figure 3B

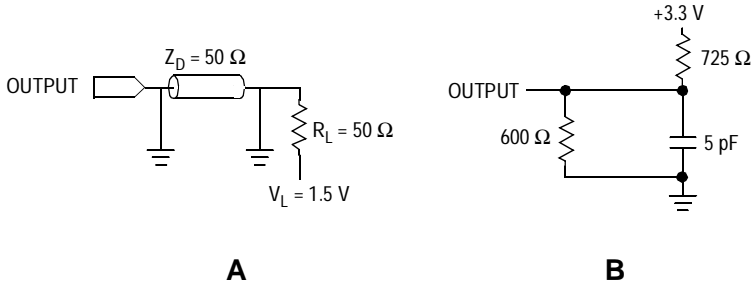
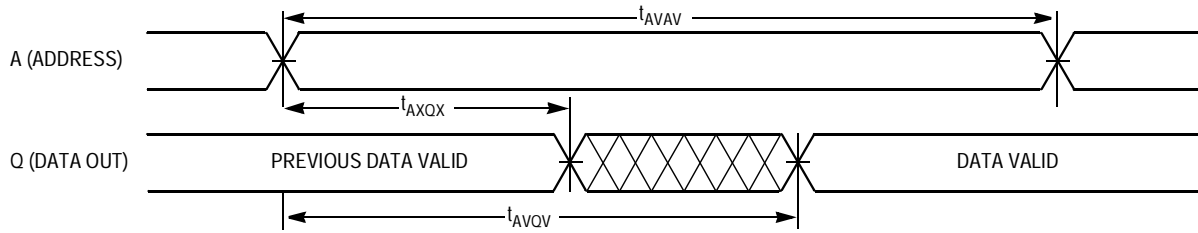


Figure 3. Output Load for ac Test

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NOTES:
 Device is continuously selected ($\bar{E} \leq V_{IL}, \bar{G} \leq V_{IL}$).

Figure 4. Read Cycle 1

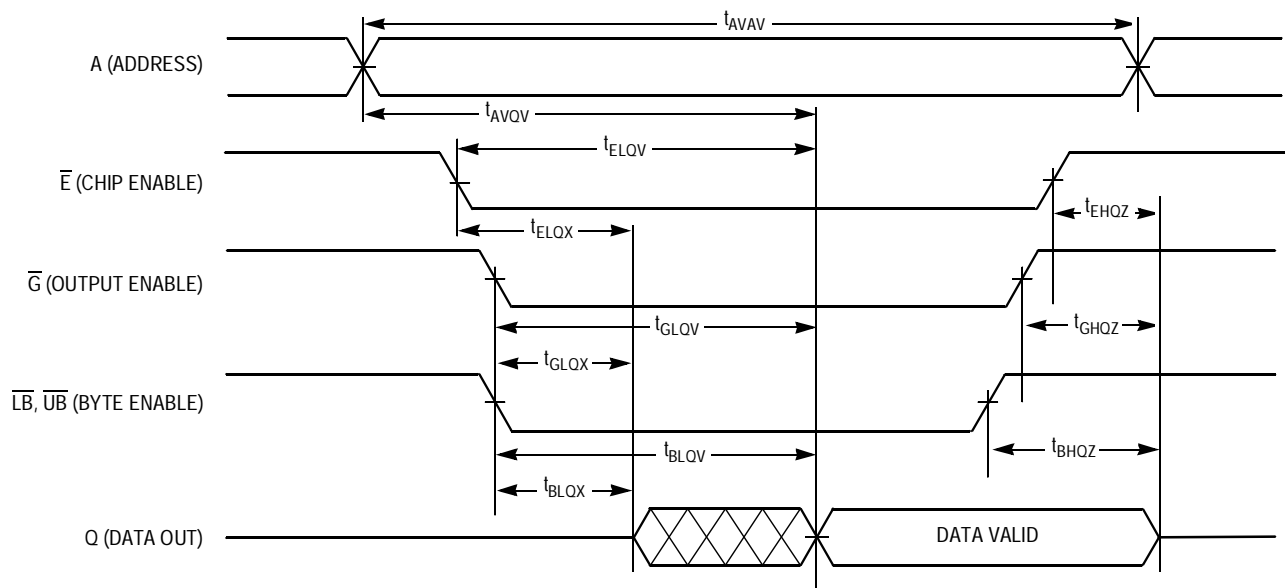


Figure 5. Read Cycle 2

Timing Specifications

Write Mode

Table 10. Write Cycle Timing 1 (\overline{W} Controlled)^{1, 2, 3, 4, 5}

Parameter	Symbol	Min	Max	Unit
Write cycle time ⁶	t_{AVAV}	35	—	ns
Address set-up time	t_{AVWL}	0	—	ns
Address valid to end of write (\overline{G} high)	t_{AVWH}	18	—	ns
Address valid to end of write (\overline{G} low)	t_{AVWH}	20	—	ns
Write pulse width (\overline{G} high)	t_{WLWH} t_{WLEH}	15	—	ns
Write pulse width (\overline{G} low)	t_{WLWH} t_{WLEH}	15	—	ns
Data valid to end of write	t_{DVWH}	10	—	ns
Data hold time	t_{WHDX}	0	—	ns
Write low to data Hi-Z ^{7, 8, 9}	t_{WLQZ}	0	12	ns
Write high to output active ^{7, 8, 9}	t_{WHQX}	3	—	ns
Write recovery time	t_{WHAX}	12	—	ns

NOTES:

- ¹ A write occurs during the overlap of \overline{E} low and \overline{W} low.
- ² Due to product sensitivities to noise, power supplies must be properly grounded and decoupled and bus contention conditions must be minimized or eliminated during read and write cycles.
- ³ If \overline{G} goes low at the same time or after \overline{W} goes low, the output will remain in a high-impedance state.
- ⁴ After \overline{W} , \overline{E} , or $\overline{UB/LB}$ has been brought high, the signal must remain in steady-state high for a minimum of 2 ns.
- ⁵ The minimum time between \overline{E} being asserted low in one cycle to \overline{E} being asserted low in a subsequent cycle is the same as the minimum cycle time allowed for the device.
- ⁶ All write cycle timings are referenced from the last valid address to the first transition address.
- ⁷ This parameter is sampled and not 100% tested.
- ⁸ Transition is measured ± 200 mV from steady-state voltage.
- ⁹ At any given voltage or temperature, $t_{WLQZ} \max < t_{WHQX} \min$.

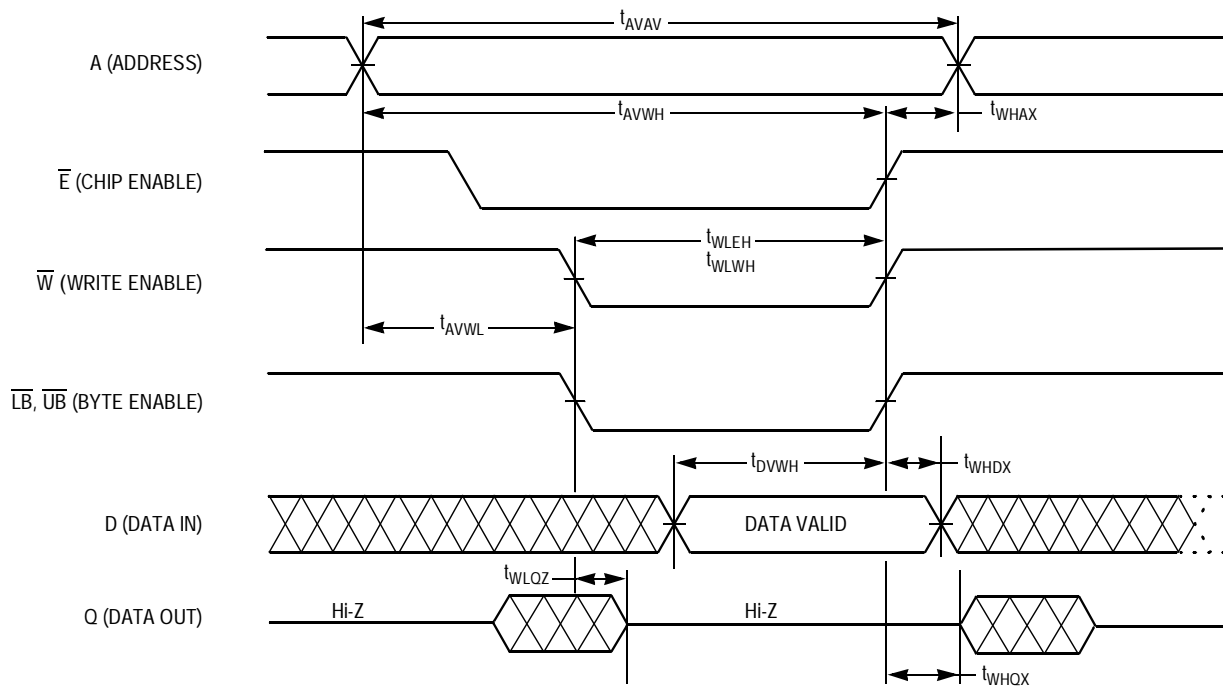

 Figure 6. Write Cycle 1 (\overline{W} Controlled)

Table 11. Write Cycle Timing 2 (\bar{E} Controlled)^{1, 2, 3, 4, 5}

Parameter	Symbol	Min	Max	Unit
Write cycle time ⁶	t_{AVAV}	35	—	ns
Address set-up time	t_{AVEL}	0	—	ns
Address valid to end of write (\bar{G} high)	t_{AVEH}	18	—	ns
Address valid to end of write (\bar{G} low)	t_{AVEH}	20	—	ns
Enable to end of write (\bar{G} high)	t_{ELEH} t_{ELWH}	15	—	ns
Enable to end of write (\bar{G} low) ^{7, 8}	t_{ELEH} t_{ELWH}	15	—	ns
Data valid to end of write	t_{DVEH}	10	—	ns
Data hold time	t_{EHDX}	0	—	ns
Write recovery time	t_{EHAX}	12	—	ns

NOTES:

- ¹ A write occurs during the overlap of \bar{E} low and \bar{W} low.
- ² Due to product sensitivities to noise, power supplies must be properly grounded and decoupled and bus contention conditions must be minimized or eliminated during read and write cycles.
- ³ If \bar{G} goes low at the same time or after \bar{W} goes low, the output will remain in a high-impedance state.
- ⁴ After \bar{W} , \bar{E} , or \bar{UB}/\bar{LB} has been brought high, the signal must remain in steady-state high for a minimum of 2 ns.
- ⁵ The minimum time between \bar{E} being asserted low in one cycle to \bar{E} being asserted low in a subsequent cycle is the same as the minimum cycle time allowed for the device.
- ⁶ All write cycle timings are referenced from the last valid address to the first transition address.
- ⁷ If \bar{E} goes low at the same time or after \bar{W} goes low, the output will remain in a high-impedance state.
- ⁸ If \bar{E} goes high at the same time or before \bar{W} goes high, the output will remain in a high-impedance state.

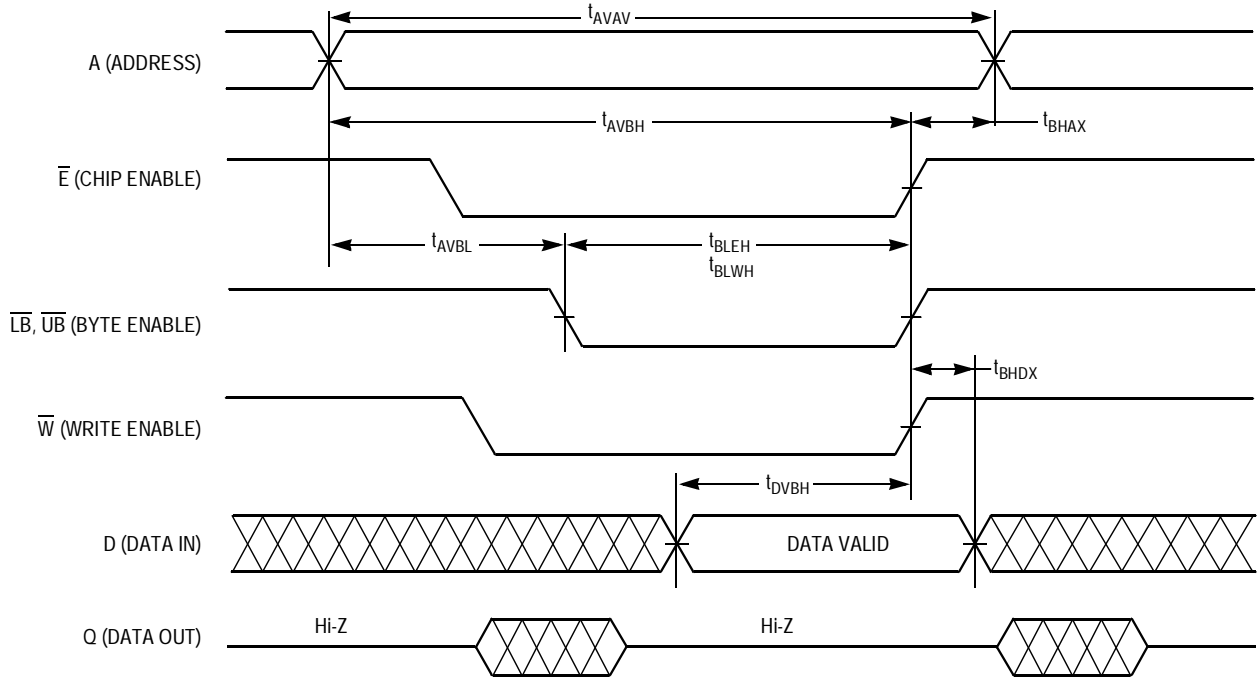


Figure 8. Write Cycle 3 ($\overline{LB}/\overline{UB}$ Controlled)

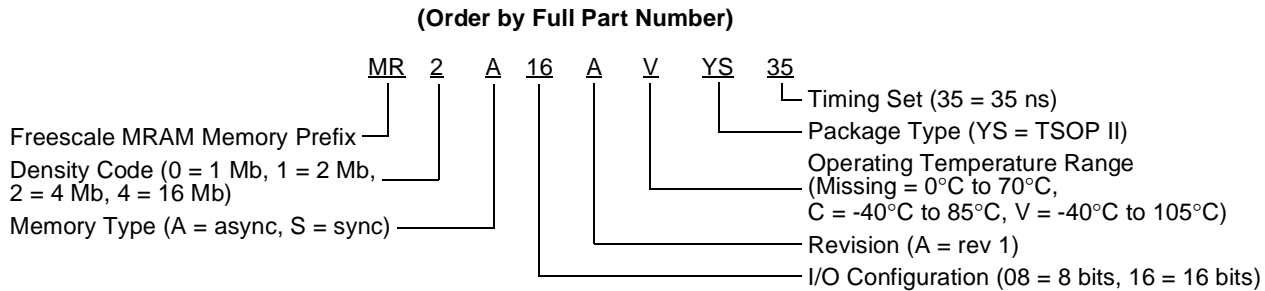
Ordering Information

This product is available in Commercial, Industrial, and Extended temperature versions.

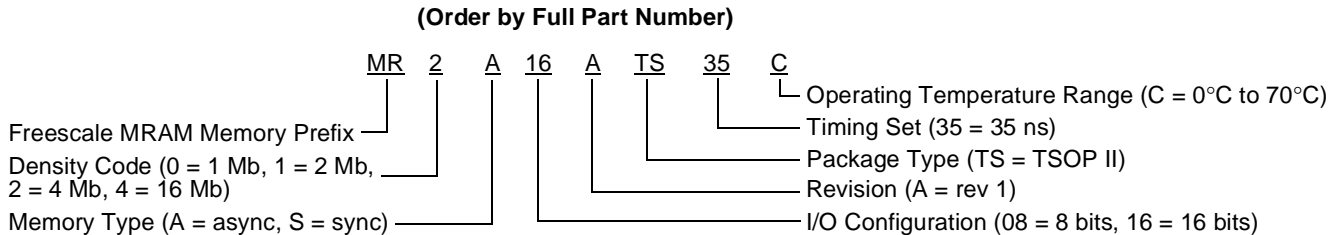
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Current Part Numbering System (New Commercial, Industrial and Extended devices)



Legacy Part Numbering System (Legacy Commercial devices)



Package Information

Table 13. Package Information

Device	Pin Count	Package Type	Designator	Case No.	Document No.	RoHS Compliant
MR2A16A	44	TSOP Type II	TS/YS ¹	924A-02	98ASS23673W	True

NOTES:

- ¹ TS and YS are both valid package codes for TSOP packages. The package is identical for both TS and YS codes.

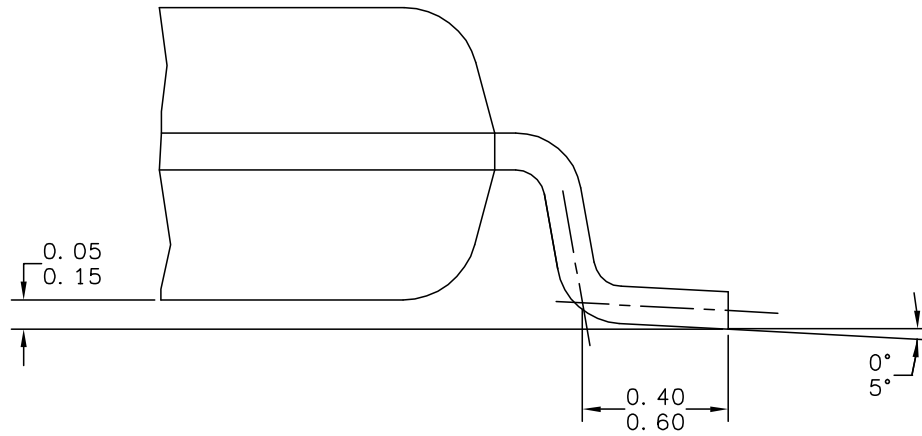
Revision History

Revision History

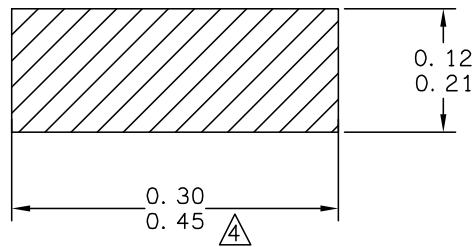
Revision	Date	Description of Change
4	18 Jun 2007	Added new Industrial and Extended temperature product information; updated part ordering information; changed to 2 ms delay after power up; power supply characteristics values updated to TBD for industrial and extended temperature devices.
5	21 Sep 2007	Changed MR2A16ATS35C product description to Legacy Commercial. Added the New Commercial temperature product (MR2A16AYS35) information. Table 3: MR2A16AYS35 $H_{max_write} = 25$ Oe. Table 4: MR2A16AYS35 has a 2 ms power up waiting period. Table 6: Applied values to TBD's in IDD specifications.
6	12 Nov 2007	Table 2: Changed IDDA to IDDR or IDDW. Table 13: Added note indicating that TS and YS are both valid package codes. Current Part Numbering System: Added commercial (missing letter) temperature range.

Mechanical Drawing

The following pages detail the package available to MR2A16A.



VIEW D
ROTATED 90° CW



SECTION E-E
40 PLACES

$\phi 0.2 \text{ (M) C A}$

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<p>TITLE: 44 LEAD TSOP, TYPE II, .400 WIDE</p>	<p>DOCUMENT NO: 98ASS23673W</p>	<p>REV: C</p>	
	<p>CASE NUMBER: 924A-02</p>	<p>17 MAY 2005</p>	
	<p>STANDARD: NON-JEDEC</p>		

NOTES:

- 1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M – 1994.
- 2. DIMENSIONS IN MILLIMETERS.
- 3. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION.
ALLOWABLE MOLD PROTRUSION IS 0.15 PER SIDE.
- 4. DIMENSION DOES NOT INCLUDE DAM BAR PROTRUSIONS.
DAM BAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.58.

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	STANDARD: NON-JEDEC		

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